



Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

RF Exposure evaluation

Report Reference No.....: CTA26041604103

FCC ID.....: 2AZW2-T50MPRO

Compiled by

(position+printed name+signature) : File administrators Zoey Cao

Supervised by

(position+printed name+signature) : Project Engineer Ace Chai

Approved by

(position+printed name+signature) : RF Manager Eric Wang

Date of issue: Apr. 23, 2026

Testing Laboratory Name: Shenzhen CTA Testing Technology Co., Ltd.

Address.....: Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name.....: Beijing Supvan Information Technology Co., Ltd.

Address.....: No.1 Gaoxin 5th Street, Huilongguan Town, Room 603, 6th Floor, Building 1, Compound 1, Beijing Changping, Beijing, 100085, China

Standard: 47CFR §1.1310
47CFR §2.1093
KDB447498 D01 General RF Exposure Guidance v06

Shenzhen CTA Testing Technology Co., Ltd. All rights reserved.

This publication may be reproduced in whole or in part for non-commercial purposes as long as the Shenzhen CTA Testing Technology Co., Ltd. is acknowledged as copyright owner and source of the material. Shenzhen CTA Testing Technology Co., Ltd. takes no responsibility for and will not assume liability for damages resulting from the reader's interpretation of the reproduced material due to its placement and context.

Test item description: Label Maker

Trade Mark: N/A

Manufacturer: Beijing Supvan Information Technology Co., Ltd.

Model/Type reference: KATASYMBOL T50M Pro

Listed Models: N/A

Ratings: Input: 5V --- 2A
Battery: 3.7V 1200mAh 4.44Wh

Result: PASS

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China
Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

TEST REPORT

Equipment under Test : Label Maker

Model /Type : KATASYMBOL T50M Pro

Listed Models : N/A

Applicant : **Beijing Supvan Information Technology Co., Ltd.**

Address : No.1 Gaoxin 5th Street, Huilongguan Town, Room 603, 6th Floor,
Building 1, Compound 1, Beijing Changping, Beijing, 100085, China

Manufacturer : **Beijing Supvan Information Technology Co., Ltd.**

Address : No.1 Gaoxin 5th Street, Huilongguan Town, Room 603, 6th Floor,
Building 1, Compound 1, Beijing Changping, Beijing, 100085, China

Test Result:	PASS
---------------------	-------------

The test report merely corresponds to the test sample.
It is not permitted to copy extracts of these test result without the written permission of
the test laboratory.

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China
Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

Contents

1	TEST STANDARDS	4
2	SUMMARY	5
2.1	General Remarks	5
2.2	Product Description	5
2.3	Special Accessories	5
2.4	Modifications	5
3	TEST ENVIRONMENT	6
3.1	Address of the test laboratory	6
3.2	Test Facility	6
3.3	Statement of the measurement uncertainty	6
4	Test limit	7
4.1	Requirement	7
4.2	Conducted Power Results	8
4.3	Manufacturing tolerance	8
4.4	Evaluation Result	9
4.5	Simultaneous Transmission for SAR Exclusion	9
5	Conclusion	9

1 TEST STANDARDS

The tests were performed according to following standards:

[ANSI C95.1-1999](#): IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

[FCC KDB 447498 D01 General RF Exposure Guidance v06](#): Mobile and Portable Device, RF Exposure, Equipment Authorization Procedures.

[FCC CFR 47 part1 1.1310](#): Radiofrequency radiation exposure limits.

[FCC CFR 47 part2 2.1093](#): Radiofrequency radiation exposure evaluation: portable devices

2 SUMMARY

2.1 General Remarks

Date of receipt of test sample	:	Apr. 16, 2026
Testing commenced on	:	Apr. 16, 2026
Testing concluded on	:	Apr. 23, 2026

2.2 Product Description

Product Name:	Label Maker
Model/Type reference:	KATASYMBOL T50M Pro
Power supply:	Input: 5V --- 2A Battery: 3.7V 1200mAh 4.44Wh
Hardware version:	V1.0
Software version:	V1.0
Testing sample ID:	CTA260416041-1# (Engineer sample) CTA260416041-2# (Normal sample)
Bluetooth BLE	
Supported type:	Bluetooth low Energy
Modulation:	GFSK
Operation frequency:	2402MHz to 2480MHz
Channel number:	40
Channel separation:	2 MHz
Antenna type:	PCB antenna
Antenna gain:	-0.36 dBi
NFC:	
Operation frequency:	13.56MHz
Modulation :	ASK
No. of Channel :	1
Antenna type:	Loop antenna
Antenna gain:	0.0dBi

2.3 Special Accessories

The following is the EUT test of the auxiliary equipment provided by the laboratory:

Description	Manufacturer	Model	Technical Parameters	Certificate	Provided by
Adapter	/	EP-TA20CBC	Input: AC 100-240V 50/60Hz Output: DC 5V 2A	/	/

2.4 Modifications

No modifications were implemented to meet testing criteria.

3 TEST ENVIRONMENT

3.1 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community,
Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

ISED#: 27890 CAB identifier: CN0127

Shenzhen CTA Testing Technology Co., Ltd. has been listed by Innovation, Science and Economic Development Canada to perform electromagnetic emission measurement.

3.3 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to TR-100028-01 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM); Uncertainties in the measurement of mobile radio equipment characteristics; Part 2" and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	9KHz~30MHz	3.02 dB	(1)
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	/	0.57 dB	(1)
Spectrum bandwidth	/	1.1%	(1)
Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1)
Time	/	±2%	(1)

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

Tel: +86-755 2322 5875 E-mail: cta@cta-test.cn Web: http://www.cta-test.cn

4 Test limit

4.1 Requirement

According to KDB447498 D01 General RF Exposure Guidance v06 Section 4.3.1 Standalone SAR test exclusion considerations: "Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition, listed below, is satisfied.

These test exclusion conditions are based on source-based time-averaged maximum conducted output power of the RF channel requiring evaluation, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions.²²

The minimum test separation distance is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander (see 5) of section 4.1). To qualify for SAR test exclusion, the test separation distances applied must be fully explained and justified by the operating configurations and exposure conditions of the transmitter and applicable host platform requirements, typically in the SAR measurement or SAR analysis report, according to the required published RF exposure KDB procedures. When no other RF exposure testing or reporting is required, a statement of justification and compliance must be included in the equipment approval, in lieu of the SAR report, to qualify for the SAR test exclusion. When required, the device specific conditions described in the other published RF exposure KDB procedures must be satisfied before applying these SAR test exclusion provisions; for example, handheld PTT two-way radios, handsets, laptops & tablets etc.²³ "

$$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f \text{ (GHz)}}] \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where:}$$

- f (GHz) is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion.

For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):³³

1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by $[1 + \log(100/f(\text{MHz}))]$

2) For test separation distances ≤ 50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$

3) SAR measurement procedures are not established below 100 MHz.

Appendix C

SAR Test Exclusion Thresholds for < 100 MHz and < 200 mm

Approximate SAR test exclusion power thresholds at selected frequencies and test separation distances are illustrated in the following table. The equation and threshold in 4.3.1 must be applied to determine SAR test exclusion.

MHz	< 50	50	60	70	80	90	100	110	120	130	140	150	160	170	180	190	mm
100	237	474	481	487	494	501	507	514	521	527	534	541	547	554	561	567	mW
50	308	617	625	634	643	651	660	669	677	686	695	703	712	721	729	738	
10	474	948	961	975	988	1001	1015	1028	1041	1055	1068	1081	1095	1108	1121	1135	
1	711	1422	1442	1462	1482	1502	1522	1542	1562	1582	1602	1622	1642	1662	1682	1702	
0.1	948	1896	1923	1949	1976	2003	2029	2056	2083	2109	2136	2163	2189	2216	2243	2269	
0.05	1019	2039	2067	2096	2125	2153	2182	2211	2239	2268	2297	2325	2354	2383	2411	2440	
0.01	1185	2370	2403	2437	2470	2503	2537	2570	2603	2637	2670	2703	2737	2770	2803	2837	

4.2 Conducted Power Results

Type	Channel	Output power (dBm)
GFSK 1Mbps	00	0.23
	19	0.00
	39	0.01

Freq. (MHz)	Field strength(max)(dBuV/m)	EIRP (max) (dBm)	Turn-up Power (dB)	Max tune up power (dBm) [P]
13.56MHz	56.71	-38.55	-39.0±1	-38.0
Note: $E = \text{EIRP} - 20\log D + 104.8$ where: E = electric field strength in dBuV/m, EIRP = equivalent isotropic radiated power in dBm D = specified measurement distance in meters. $\text{EIRP} = E - 104.8 + 20\log D$, $D = 3$				

Frequency(MHz)	Electric Field (dBuV/m)	Max tune up power (dBm) [P]	Power to antenna (mW)	Min. distance(mm)	Limit(mW)	Limit Ratio
13.56	56.71	-38.0	0.0002	5	442.65	0.0000

Remark: Limit=474*1/2*(1+log(100/13.56))=442.65

4.3 Manufacturing tolerance

Mode	Max. Peak Conducted Output Power (dBm)	Max. tune-up
BLE	0.23	0.0±1

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

4.4 Evaluation Result

Evaluation Results

Band/Mode	f (GHz)	Antenna Distance (mm)	RF output power (including tune-up tolerance)		SAR Test Exclusion Threshold	SAR Test Exclusion Threshold Limit	SAR Test Exclusion	Limit Ratio
			dBm	mW				
BLE	2.480	5	1.0	1.2589	0.3965	3.0	Yes	0.1322

4.5 Simultaneous Transmission for SAR Exclusion

The sample BLE/NFC supports difference antenna, need consider simultaneous transmission;
 Σ of (the highest measured or estimated $SAR_{BLE} + SAR_{NFC}$) = $(0.1322 + 0.0000) = 0.1322 < 1.0$;

5 Conclusion

The measurement results comply with the FCC Limit per 47 CFR 2.1093 for the uncontrolled RF Exposure and SAR Exclusion Threshold per KDB 447498 D01v06

***** End of Report *****